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## GSWP100W-EVBPA

# 100W GaN E-HEMT Wireless Power Transfer Evaluation Board, Optimized for Class EF<sub>2</sub> Amplifiers

Technical Manual



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**DANGER!**

Electrical Shock Hazard - Hazardous high voltage may be present on the board during the test and even brief contact during operation may result in severe injury or death. Follow all locally approved safety procedures when working around high voltage.

Never leave the board operating unattended. After it is de-energized, always wait until all capacitors are discharged before touching the board.

**This board should be handled by qualified personnel ONLY.**



PCB surface and devices can become hot. Contact may cause burns. Do not touch!

**CAUTION**

This product contains parts that are susceptible to damage by electrostatic discharge (ESD) or exposure to voltages in excess of the specified voltage. Always follow ESD prevention procedures when handling the product. Avoid applying excessive voltages to the power supply terminals or signal inputs or outputs, always connected to the load during the test on-going.

## Introduction to Magnetic Resonant Wireless Power Transfer

Recent technological advances in power semiconductors are enabling Wireless Power Transfer (WPT) as a technically and commercially viable option for charging and powering equipment across a wide range of markets, applications, and power levels.

Inductive charging has been in use for a number of years; however, it's burdened with limitations that restrict it to low power applications with tightly controlled alignment between the transmitter and receiver.

A more advantageous approach, magnetic resonant charging, addresses these shortcomings by using a high frequency oscillating magnetic field to transfer energy. The benefits that magnetic resonant charging offers include variable spacing between the transmitter and receiver, the ability to charge through materials such as a desk or an enclosure, one-to-many charging, ease of installation, suitability for high power levels, and fast charging. Table 1 provides a comparison between inductive charging and magnetic resonant charging.

GaN E-HEMTs are a key enabler of magnetic resonant charging because their extremely fast switching speeds, on the order of a few nanoseconds, result in very low switching losses. This allows them to operate efficiently at very high frequencies, such as the 6.78MHz that is commonly used for magnetic resonant charging.

**Table 1** A comparison of Inductive charging and Magnetic Resonant charging

| Charging technology | Inductive                | Magnetic Resonant                             |
|---------------------|--------------------------|---|
| Frequency range     | 80-300kHz                | 6.78MHz                                       |
| Max transfer range  | 5mm                      | <b>50mm</b>                                   |
| Multi-device        | No                       | <b>Yes, at different power levels</b>         |
| Spatial Freedom     | Low                      | <b>High</b>                                   |
| Power Range         | Low & limited<br>30W max | <b>Broad &amp; versatile<br/>50W to 20kW+</b> |
| Efficiency          | Limited to 80%           | <b>High: up to 95%</b>                        |

A high-level block diagram of a resonant wireless power transfer system is shown in Figure 1. The transmit section is composed of a power amplifier, an impedance matching circuit and a transmit coil. High frequency energy is transferred wirelessly at 6.78MHz to the receive circuit which is comprised of a receive coil, an impedance matching circuit and a rectifier.

The GSWP100W-EVBPA evaluation board is designed to support and expedite the innovation of WPT systems by providing the Power Amplifier, the most challenging aspect of the system design.

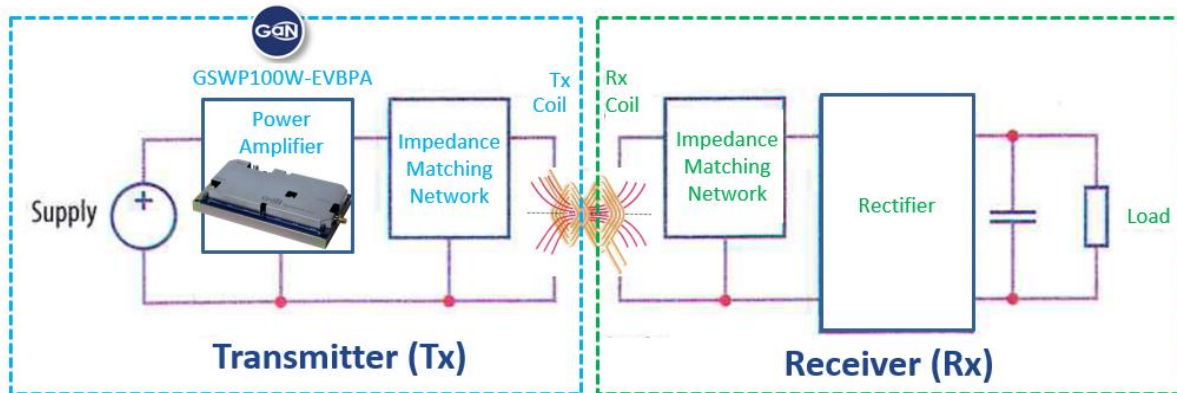


Figure 1 - A magnetic resonant wireless power transfer design.

## Evaluation board overview

The GSWP100W-EVBPA uses GaN Systems’ GS61008P E-HEMTs in a 6.78MHz class EF2 power amplifier. The GS61008Ps are used with the integrated high-speed TI LMG1210 gate driver in a push-pull configuration. The outputs of the LMG1210 can provide switching transition speeds in the nano-seconds range for hard switching applications.

This User’s Guide includes a circuit description, a quick-start guide and measurement results.

## Evaluation Kit Contents and Requirements

### Kit Contents

The GSWP100W-EVBPA includes the following hardware for evaluating the GaN E-HEMT 100W power amplifier.

Table 2 GSWP100W-EVBPA Evaluation Kit Contents

| Quantity | Description  |
|----------|--|
| 1        | GaN E-HEMT GS61008P WPT PA evaluation board assembly |
| 1        | WPT PA heatsink                                      |
| 1        | WPT PA EMC shield                                    |
| 2        | 2 pins DC cord                                       |

### Hardware Requirements

In order to evaluate the performance of the evaluation board, the following equipment is required:

- DC power supply 100V/15A
- TEK scope with current probe TCM0030A
- Fluke 87 multimeter for input current
- 50dB 500W attenuator as load
- Spectrum analyzer
- Power meter
- Thermal meter

### Evaluation Board Assembly Overview

The evaluation board (EVB) is assembled with two GS61008P E-HEMT transistors and two LMG1210 GaN E-HEMT drivers. Headers are included for monitoring the signal input, signal output, power connections and detection monitoring signals. Probe points are included for waveform measurements. Provision has been made for a single, suitable heatsink to be fastened against the two E-HEMTs, using the two holes in the center of the bottom heatsink.

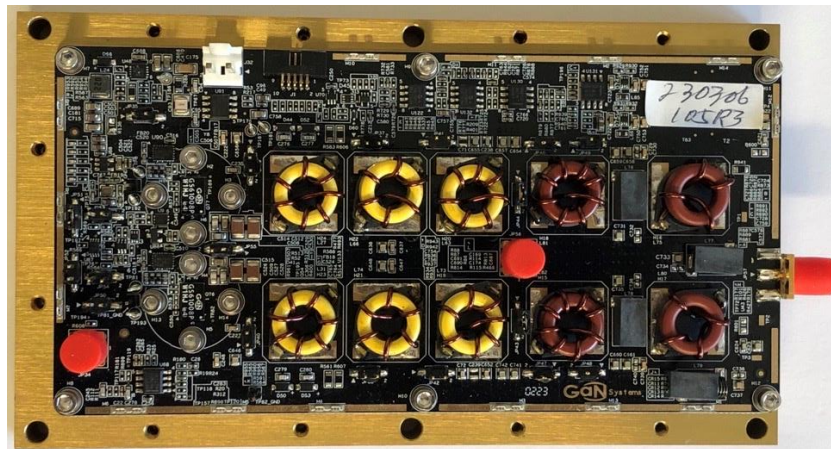


Figure 2 • Top side of GSWP100W-EVBPA Evaluation Board Assembly



Figure 3 • Bottom side of GSWP100W-EVBPA Evaluation Board Assembly, showing copper coins

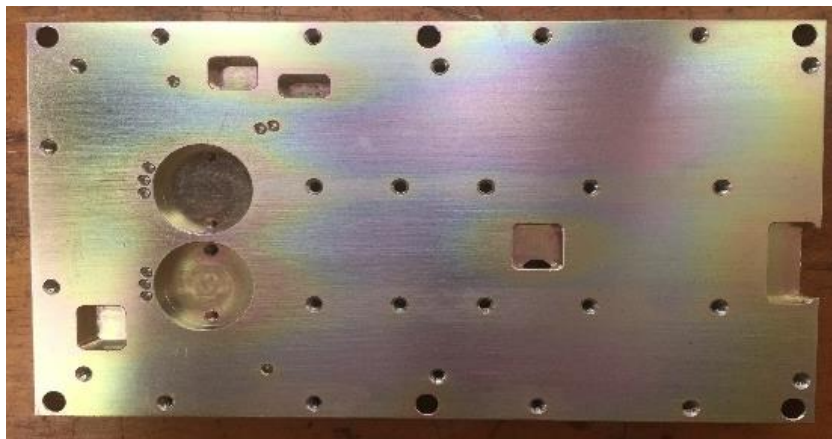


Figure 4 • GSWP100W-EVBPA Evaluation Board heatsink

## Block Diagram

The block diagram of the evaluation board is provided in Figures 5 through 7.

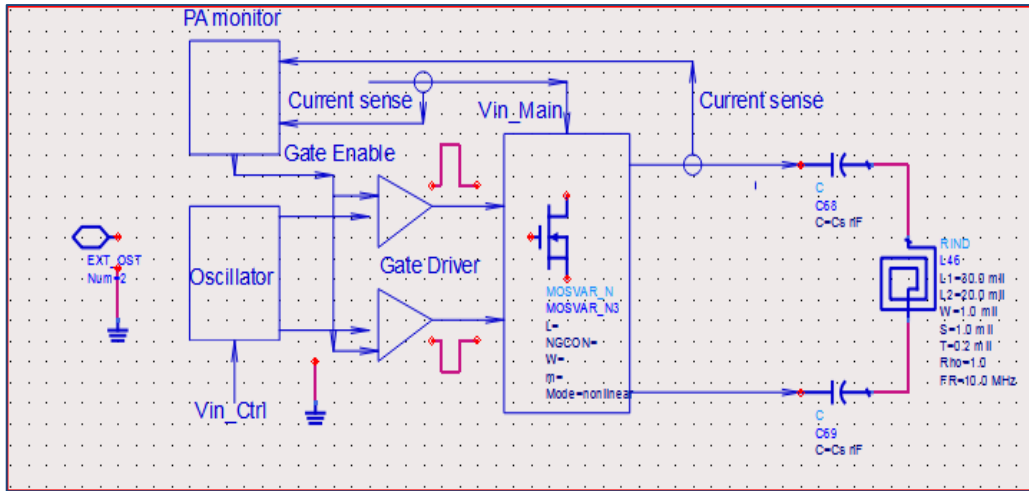


Figure 5 • GSWP100W-EVBPA WPT Push-Pull EVB Block Diagram

Note: The coil in Figure 5 is not included in the EVB.

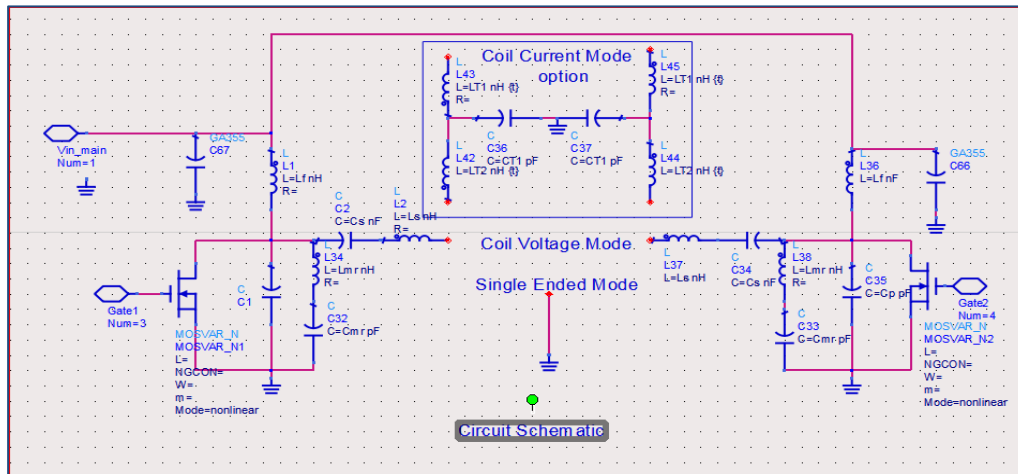


Figure 6 • GSWP100W-EVBPA WPT Class EF2 PA Block Diagram

Note: The switch devices are GaN Systems' GS61008P E-HEMTSs

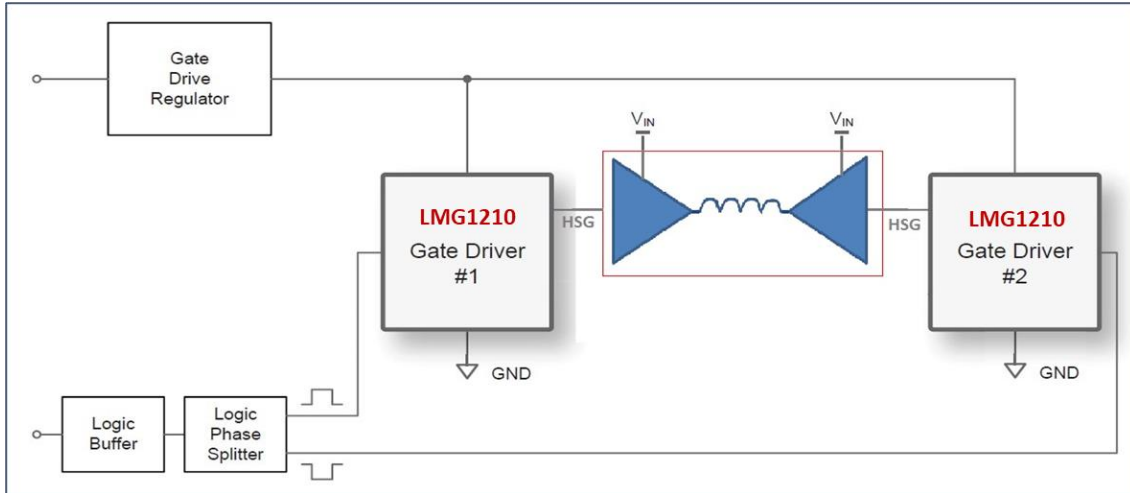


Figure 7 • GSWP100W-EVBPA WPT driver Block Diagram

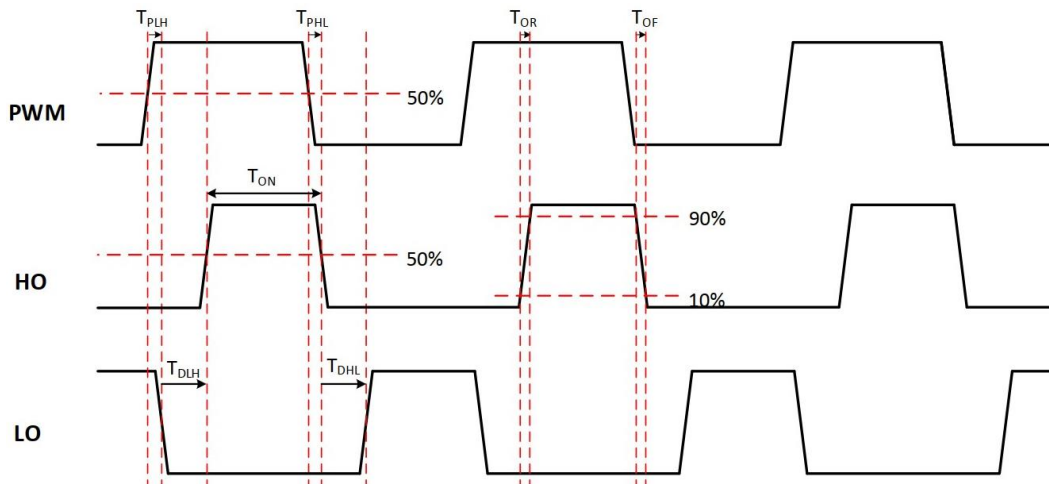


Figure 8 • LMG1210 Dead-time Waveforms and Duty Cycle Setting

LMG1210 drivers in this EVB work in PWM mode. The dead time can be set with a resistor ( $R_{ext}$ ) placed between DHL/DLH and  $V_{ss}$ . Equation 1 is the calculation for the dead time ( $t_{dt}$ ),  $t_{dt}$  in ns and  $R_{ext}$  in kohm.

$$R_{ext} = (900 / t_{dt}) - 25 \quad (1)$$

## Circuit Description

The Push-Pull circuit is comprised of two single ended PAs which share a common supply, however; the impedance matching, and EMI filters are separated.

The high-side E-HEMTs are powered by a DC source, referred to as the HV supply. It is connected through J32. The voltage of this source does not exceed 35V<sub>DC</sub>.

The low-voltage logic circuitry runs off a 3.3V<sub>DC</sub> voltage regulator, U88, which is powered by +5V<sub>DC</sub>. There are two options of getting +5V DC input. Option one is supplied externally through JP35. The 2<sup>nd</sup> option is internally from the +5V DC output of the voltage regulator U48. In R3, internal 5V is enable, which can support the drain current up to 7A. These two options of +5V<sub>DC</sub> are switched by a 0ohm 0805 footprint resistor R138. Designers can switch these two options either way of with/without 5V input through JP35 by removing R138 or soldering it on. The difference is the internal 5V DC supplier will be on when drain voltage higher than 5.4V due to the internal regulator threshold voltage. The detailed configurations can be seen in Table 4. Please note that Evaluation Bench Test Setup in this user guide is based on the option with 5V input through JP35. EVB default setting is external 5V input (R138 is disconnected on PCBA).

The +5V<sub>DC</sub> rail also feeds two LMG1210 drivers U86 and U90, which are driven independently by U87, a common logic D-type flip/flop. U87 has a frequency divider configuration, which is driven by a crystal oscillator Y8 at a frequency of 13.56MHz. The two LMG1210 gate drivers have internal LDO, its rated input supply voltage is up to 18V if using the internal LDO.

The PA can be configured to operate in several different modes, which include.

- Push-pull configuration with an EMI filter
- Operation without an EMI filter
- Operation with an external oscillator signal input. Users can run multiple PAs together at the same frequency for high power operation.
- With /Without 5V input (external/internal 5V options)

Detailed operation procedures and setup for these alternative configurations are provided in the section titled “quick start guide”.

The PA includes an over-temperature protection circuit. Temperature sensor U9, placed close to the GS61008P E-HEMTs, monitors their temperature. In an over-temperature condition, the LMG1210 driver will be disabled through U133 and stop driving the E-HEMTs. The design also includes circuitry to protect against over-current, and load mismatch.

The evaluation board includes an EMI filter, comprised of one low pass filter and one notch filter. The output of PA can be configured, through jumpers, to operate either with or without an EMI filter. The detailed jumper and SMA connector configurations are listed in Table 4

For convenience, test points are provided to monitor and measure the electrical signals. A description of the test points and diagram of their location is provided in Table 5.

The PA also includes a Micro Controller Unit (MCU) monitor interface header, J1. The signals

available through J1 can be used to control the PA system for close loop in the WPT system. A definition of the signals available on header J1 is provided in Figure 9.

- Monitor signals on J1.
- Pin1: PA GND
- Pin2: 5V Input
- Pin3: output voltage detection
- Pin4: PA HV DC current
- Pin5: 3.3V DC
- Pin6: over voltage and current
- Pin7: output power detection
- Pin8: Temperature sensor voltage
- Pin9: PA HV DC input
- Pin10: Fan control enable

Figure 9 • MCU interface definition. Signals on J1

The PA connectivity is depicted in Figure 11 and includes the RF input and output, the DC biases and the MCU monitor interface.

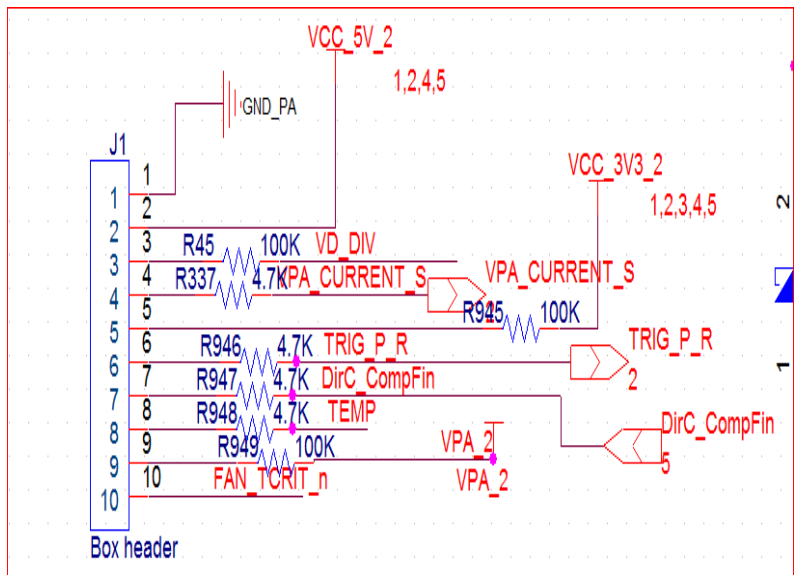


Figure 10 • Circuit Connectivity

## Protection Circuit

The PA includes circuitry to protect against input DC overcurrent, device over temperature, output RF overvoltage and Voltage Standing Wave Ratio (VSWR) protection. The protection signals are combined by U133, a 3 inputs OR gate logic chip, and will shut the driver down under a fault condition.

Input DC overcurrent protection (OCP): U91 is the DC current sensor chip, which can handle a maximum of 10A. The output of the current sensor chip is a current sense signal that goes thru buffer OP U122 and is compared to a reference voltage. The reference voltage is set with R101 and R177. Upon an over current event, a signal is generated to signal OCP\_TRIG.

Overvoltage protection (OVP): The design includes overvoltage protection circuitry for both the high side and the low side. The high side voltage sensor is comprised of C276, C277, and two Schottky diodes; D52 and D44. C276/C277 form a voltage divider, the ratio of which can be changed. Two diodes rectify the RF signal to DC thru C278/C22 and R111 and the resulting voltage represents the high side output. The low side circuit is similar. It's comprised of C279, C280, and two diode D50, D53. These two voltage detection signals go to a two-channel comparator U68 and are combined with OR gate U70 into one overvoltage trigger, OVP\_TRIG.

The OVP and OCP go into a hard combine circuit D45, which a dual diode in one. To generate an overcurrent / overvoltage protection trigger signal.

Standing Wave Ratio (SWR) detection: two of coupler, T2, T83, comprise of the broad band bidirectional coupler. The reflection signal goes thru D74, C723, C762, it turns into DC signal which goes thru the buffer OP U132 into comparator U131, of which the reference voltage is set by the R890/R892, the trigger point can be set by the reference voltage, which is refer the SWR. The direction of the coupler is around 15dB at 6.78MHz.

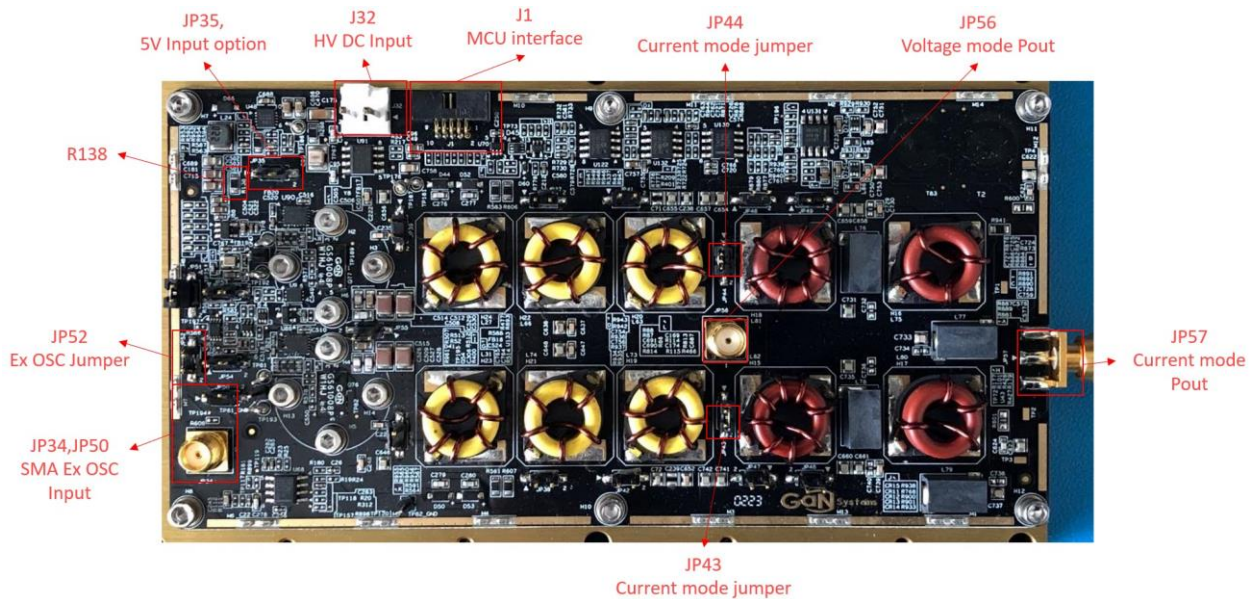


Figure 11 • Connectivity locations

## Thermal Management

Thermal management of the GaN E-HEMTs in this RF power system is a critical aspect of the design. Maintaining low device temperatures through proper thermal management enhances the system reliability and extends the range of operating temperature.

The GS61008P are bottom-side cooled devices that use GaN<sup>PX</sup>® packaging, designed for optimal thermal performance. For effective thermal management, a hole is cut out of the PCB to permit access to the copper coins. The two GS61008Ps' bottom side thermal pads are soldered directly onto the copper coins on the bottom side of the PCB and the Gate, Drain and Source signals are routed on the top side of the PCB. This set up provides an ultra-low thermal impedance from the die to the copper coins.

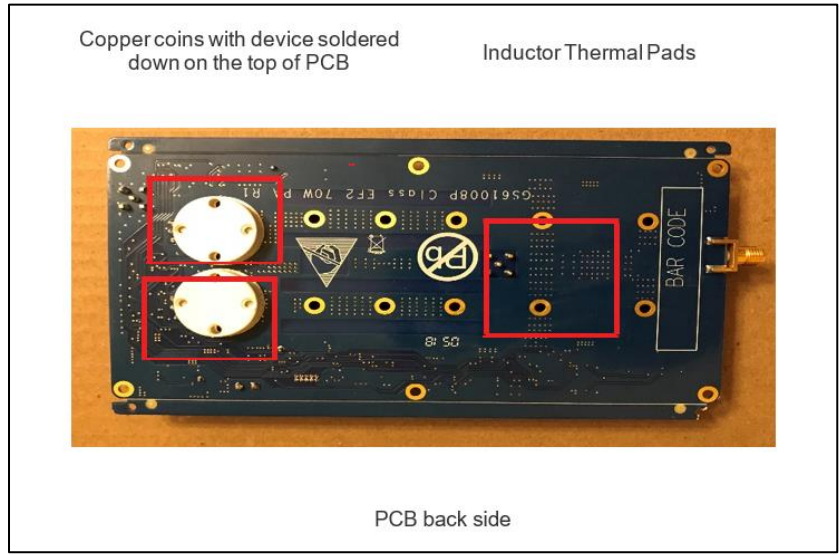


Figure 12 • Copper coins soldered beneath PCB and devices top PCB



Figure 13 • Aluminum heatsink with housing for two copper coins.

## Quick Start Guide

The GSWP100W-EVBPA EVB is designed to as a platform for evaluating the GS61008P E-HEMTs in a Push-Pull Class EF2 PA for WPT. This chapter will guide the user through the evaluation board overview, PA operation, bench setup and test results.

## Evaluation Board Overview

### Kit Contents

The GSWP100W-EVBPA evaluation kit contains:

- Power Amplifier evaluation board assembly
- PA heatsink
- PA EMC shield
- 2 pins DC cord

### Evaluation board specifications

**Table 3:** EVB specifications:

| PARAMETER               | SPECS                 |
|-------------------------|-----------------------|
| Input Voltage range     | 33V <sub>DC</sub> max |
| Tx output power         | 100W                  |
| Tx efficiency (peak)    | 88%                   |
| Topology/Class          | EF2                   |
| Frequency               | 6.78 MHz              |
| Switching type          | Push/Pull             |
| GaN Systems part number | GS61008P              |
| Number of GS devices    | 2                     |
| Optimized RL (load)     | 30Ω                   |
| Constant current mode   | optional              |

The maximum operating specifications of the evaluation board are as follows:

- Maximum HV supply input operating voltage of 33V<sub>DC</sub>
- Maximum LV supply input operating voltage of 7V<sub>DC</sub>
- Frequency of operation of 6.78MHz.
- Maximum output power of 100W \*

Note: \* The maximum output power depends on the input voltage, as shown in Figures 20 and

23.

### Configurations

The PA can be configured into two different operating options: voltage mode, current mode. Table 4 describes how to configure the board using the jumpers provided.

**Table 4:** Configuration options

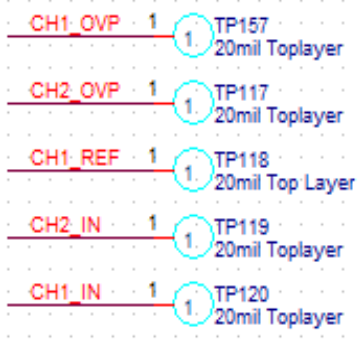
| Jumper                                   | Option                            | Jumper on/off       |
|--|-----------------------------------|---------------------|
| <b>JP51</b>                              | Internal oscillator (default)     | JP51 on / JP52 off  |
| <b>JP52</b>                              | External oscillator               | JP51 off / JP52 on  |
| <b>Voltage mode (without EMI filter)</b> | Voltage mode                      | JP42 off / JP44 off |
| <b>Current mode (with EMI filter)</b>    | Current mode                      | JP43 off / JP44 on  |
| <b>Voltage mode output</b>               | RF output                         | JP56                |
| <b>Current mode output</b>               | RF output                         | JP57                |
| <b>With 5V input through JP35</b>        | External +5V <sub>DC</sub> source | R138 removed        |
| <b>Without 5V input through JP35</b>     | Internal +5V <sub>DC</sub> source | R138 soldered       |

Test points

To monitor the performance of PA, test points are provided and as described in Table 5. All test points are available on the top side of the board, none are on the bottom side. The test points locations are silkscreened on the PCB.

Table 5: Test point description

| Test point | Description                 |
|------------|-----------------------------|
| TP197      | U90 input (PE29102 driver)  |
| TP76       | U6 input (PE29102 driver)   |
| TP8        | Q77 Gate voltage            |
| TP81       | Q76 Gate voltage            |
| TP189      | Q77 Drain voltage           |
| TP82       | Q76 Drain voltage           |
| TP176      | 60V DC current detection    |
| TP194      | External oscillator monitor |



Evaluation Bench Test Setup

The test bench setup for the GSWP100W-EVBPA EVB is shown in Figure 14. Ensure that the safety precautions mentioned on page 2 are followed.

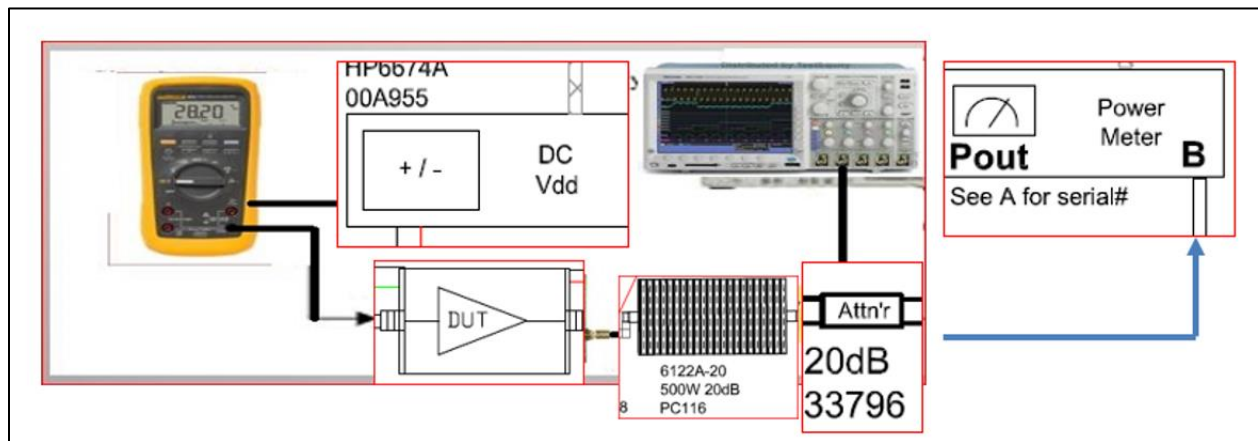


Figure 14 • Bench setup

A recommended list equipment is provided below. Equipment with equivalent performance specifications can be substituted. In all cases, ensure that it is well calibration.

- DC power supply 100V/15A
- TEK scope with current probe TCM0030A

- 
- Fluke 87 multimeter for input current
  - 50dB 500W attenuator as load
  - Spectrum analyzer: RIGOL DSA 815
  - Power meter: GiGa 8542C
  - Thermal meter, sensor is located at screw of copper coin

Note: The WPT test setup is normally a non-50Ω system. If the PA is tested under a non-50Ω system, the measurement results may not correlate with 50Ω system due to the mismatch.

## Hardware Operation

The following steps provide a guideline for proper hardware operation and configuration.

- 1) First, set the current limit to 0.3A for the +5V<sub>DC</sub> supply feeding JP35.
- 2) Set the current limit to 1A for the HV DC supply feeding J32 at a voltage of between +10V<sub>DC</sub> and +30V<sub>DC</sub>.
- 3) Verify that all DC power supplies are turned off.
- 4) Make sure the load is connected to JP56 or JP57.
- 5) Verify the Class EF2 waveform via test points TP8, TP81 with J32 +5V<sub>DC</sub>.
- 6) Connect the V<sub>DD</sub> power supply to J32. Apply between 4V to +10V<sub>DC</sub> to J32. Read the output power at JP56 or JP57.
- 7) Turn on the HV supply to the desired value. Do not exceed the absolute maximum voltage of +35V<sub>DC</sub>. Keep the J32 +5V<sub>DC</sub> on.
- 8) To power the evaluation board down, reverse the steps above.

## Measurement Technique

When measuring the high frequency content switch node, care must be taken to avoid long ground leads. Measure the switch node by placing the oscilloscope probe tip at JP192 and JP193 (designed for this purpose) or to the closest ground screws. Refer to Figure 15 for the proper probe technique.

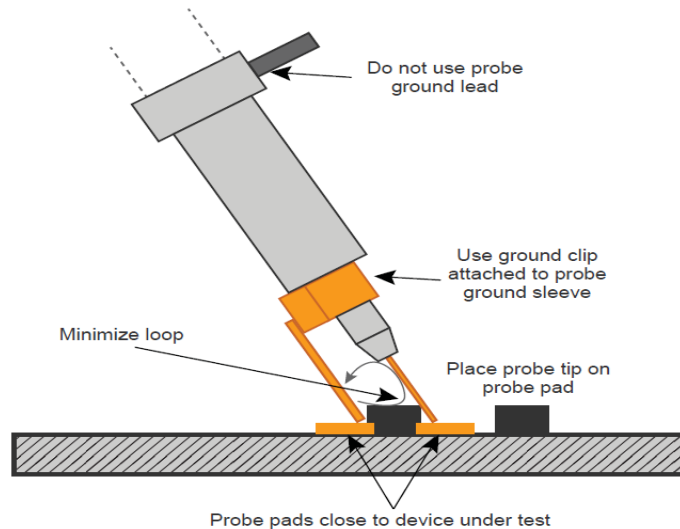


Figure 15 • Proper oscilloscope probe measurement technique

## PA Performance without EMI filter

### Power-on Procedure without EMI filter

- An additional heatsink may be required. The PA heatsink is provided with threaded hole locations that can be used to attach the heatsink to the heatsink with 4-40 screws. To ensure excellent thermal conduction, apply thermal grease to the PA / heatsink interface before screwing the units together. Enough thermal grease should be applied so that a small amount extrudes on all four sides as the screws are tightened. Wipe the assembly clean.
- Make sure jumpers JP43/JP44 are off
- Solder the wires with the SMA connector to JP56.
- Connector the load to JP56
- Plug the 5V<sub>DC</sub> supply into JP35. Pin 1: positive. Pin 2: negative. Turn the supply on and set the DC input voltage to 5V
- Plug the HV supply into J32. Pin 1: positive. Pin 2: negative. Turn the supply on and ramp the voltage from 0V to 10V.
- Monitor the test point voltage by comparing the power meter measurement to GaN Systems' test data which is available in Appendix A.
- If the measurements correlate, increase the HV supply to 35V<sub>DC</sub>.
- **IMPORTANT:** Ensure the 5V<sub>DC</sub> supply does not exceed 6V during testing.

## Evaluation Results-without EMI filter

The evaluation results for performance without an EMI filter are captured in Figures 16 through 20.



Figure 16 • Oscilloscope Plot Showing Both GS61008P Gate Node Signals at TP8, TP81

For a Class EF2 power amplifier topology, the optimal efficiency is achieved at a duty cycle of approximately 35%. At that operating point, the PA can work under very ZVS wide impedance range with high efficiency. The PA duty cycle is controlled by gate driver LMG1210. For a detailed time-delay design please refer to Figure 8 and Equation 1. The total resistor value of R955/R565 dominates the dead time of U86, and the delay time of U90 is controlled by R953/R592. Both LMG1210 drivers use the low side path. The high side path also works at the same time while the HO pin is floated.

Typical waveforms at the devices Drain node are shown in Figure 17. Channel 1 is shown in yellow and channel 2 is shown in blue. At 35V<sub>DC</sub> input voltage, the output power is 70W before the EMI filter.



Figure 17 • Oscilloscope Plot Showing Both GS61008P Drain Node Signals

The ratio of maximum Drain voltage and input DC voltage is 2.07 which is ideal for a class EF2 amplifier. This operating condition eliminates voltage stress on the transistors and has low second harmonics.

Switch mode Power Amplifiers have a lot of harmonics at the output. One significant advantage of the Class EF2 topology is that it has a lower 2<sup>nd</sup> harmonic when compared to other PA topologies. This advantage results in a Class EF2 PA with much better EMI performance.

Figure 18 shows the spectrum of the PA at 100W output power without an EMI filter. Compared to the fundamental frequency, the 2<sup>nd</sup> harmonic is -46dBc, the 3<sup>rd</sup> harmonic is -15dBc, and the 4<sup>th</sup> harmonic is -38dBc. This extremely low 2<sup>nd</sup> harmonic performance makes it much easier to filter out the PA’s high order harmonic. This allows designers to meet EMI specifications and regulations without additional cost.

The PA’s output power and efficiency are shown in Figure 19. This PA delivers 91% efficiency at 70W output power and 35V<sub>DC</sub> input voltage. This remarkable efficiency performance makes PA the best candidate of the WPT systems, and particularly advantageous for high power applications such as drone, autonomous robot and E-bike charging.

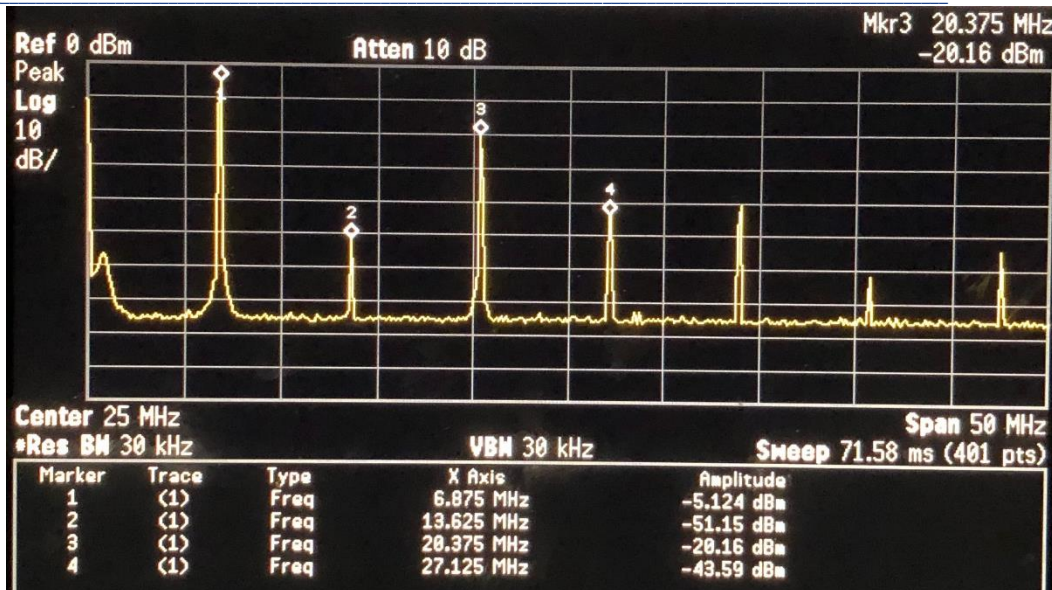


Figure 18 • Spectrum Plot of output terminal JP56 SMA after 53.6dB attenuation at 70W output power

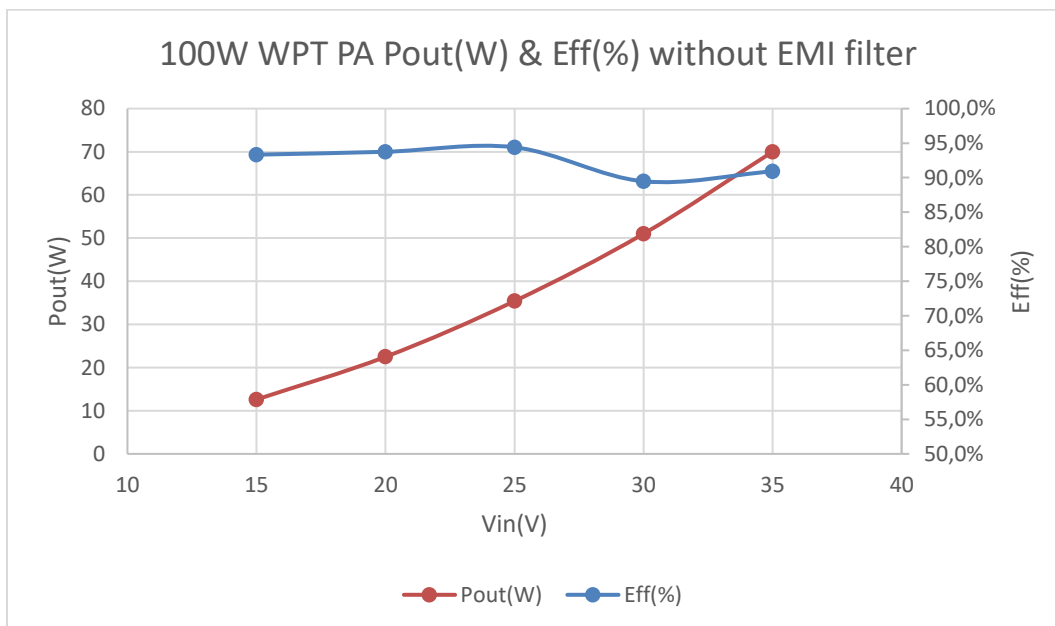


Figure 19 • Output power and efficiency of PA without EMI filter at JP56 SMA

Note: Without the EMI filter, the maximum power level is limited to 70W, due to the 50Ω test.

The PA’s system reliability is optimized when the temperature rise of each device is kept to a minimum, including that of the GaN E-HEMTs. The GS61008Ps are especially well suited in this regard, for a number of reasons. First, they have very low switching losses which allows them to operate at high efficiency and a low temperature rise at 6.78MHz, the common frequency used for resonant wireless power transfer. Secondly, the bottom-side cooled GaNPX® packaging provides an extremely low thermal impedance for efficient heat transfer to the heatsink, thereby drawing heat out of the device.

This GaN based design is able to operate over a wide ambient temperature and with convection cooling, eliminating the need for cooling fans. These advantages support a PA design with excellent thermal performance up to 100W output power.

The temperature plot of the PA design was measured and captured with a SEEK thermal camera and is shown in Figure 20. The hottest devices are the first inductors, with the hottest inductor recording 20°C above ambient. The temperature rise of the GaN E-HEMTs, by comparison, is only 2°C. Because the GaN E-HEMTs run very cool, this allows operation over a very wide temperature range and extends operation to a higher power level while simultaneously simplifying the cooling system design and reducing the cost.

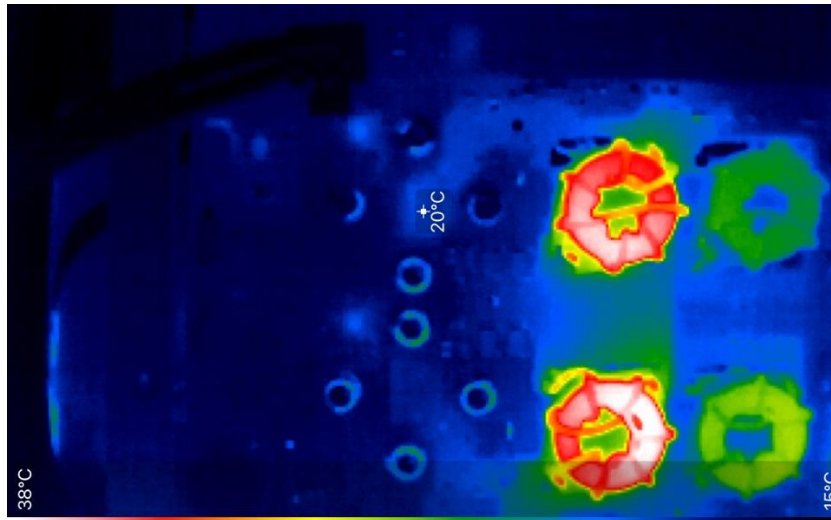


Figure 20 • Thermal measurement of PA without EMI filter at 70W output power

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## PA Performance with EMI filter

### Power-on Procedure with EMI filter

- An additional heatsink may be required. The PA heatsink is provided with threaded hole locations that can be used to attach the heatsink to the heatsink with 4-40 screws. To ensure excellent thermal conduction, apply thermal grease to the PA / heatsink interface before screwing the units together. Enough thermal grease should be applied so that a small amount extrudes on all four sides as the screws are tightened. Wipe the assembly clean.
- Make sure jumpers JP43/JP44 are on
- Do not attach a cable or wire to JP56.
- Connect the load to JP57.
- Plug 5V<sub>DC</sub> supply into JP35. Pin 1: positive. Pin 2: negative. Adjust the voltage to 5V.
- Plug the HV supply into J32. Pin 1: positive. Pin 2: negative. Turn the supply on and ramp the voltage from 0V to 10V
- Monitor the test point voltage by comparing the power meter measurement to GaN Systems' test data which is available in Appendix A.
- If the measurements correlate, increase the HV supply to 26V<sub>DC</sub>.
- **IMPORTANT:** Ensure the 5V<sub>DC</sub> supply does not exceed 6V during testing.
- The optimized impedance of the current mode PA is around 30Ω. Using a 50Ω load will not cause damage, however, the system will operate at a lower efficiency.

### Evaluation Results-with EMI filter

For improved EMI performance, a filter can be used to reduce the higher order harmonics in each side of the push-pull arm. Also, the addition of an EMI filter converts the PA from operating in voltage mode to current mode, which provides a constant current for the WPT system.

The frequency spectrum of the PA is depicted in Figure 21. The 3rd harmonic rejection is around -45dBc, with more than -45dBc rejection on high order harmonics. This outstanding performance will greatly help the WPT system level EMI performance.



Figure 21 • Spectrum plot of output terminal JP57 SMA after 53.6dB attenuation at 100W output power

The output power and efficiency with an EMI filter are shown in Figure 22. This PA design delivers 92% efficiency at 100W output power and 26.6V<sub>DC</sub> input voltage. This efficiency performance is lower than the one of without EMI filter due to the insertion and mismatch loss from the EMI filter. The design of EMI filter is optimal at 30 Ω, but the data is taken at 50 Ω.

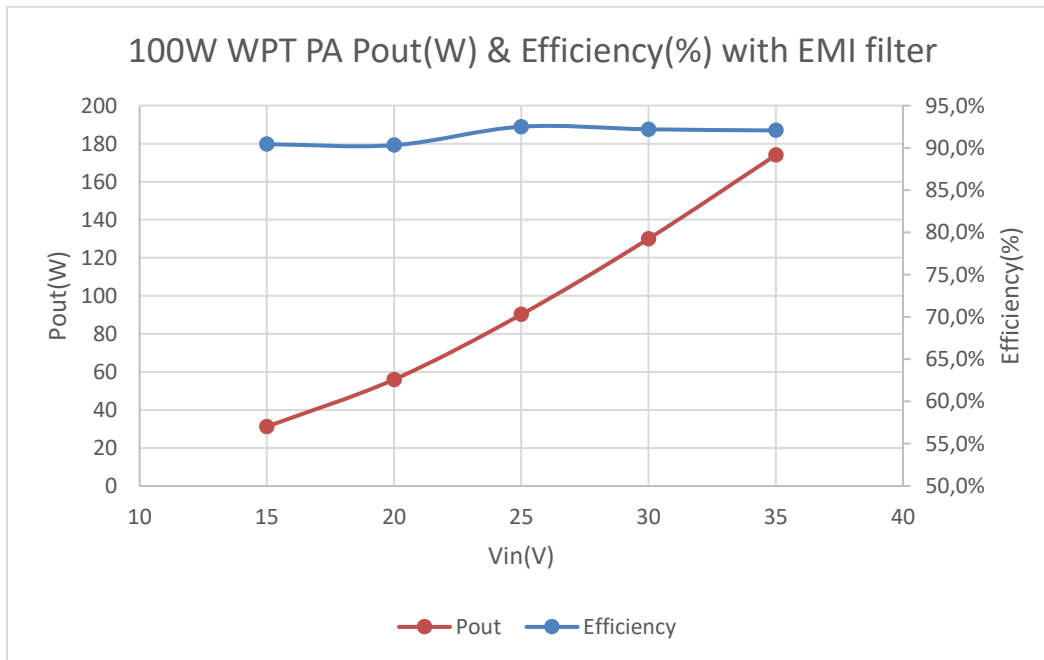


Figure 22 • GSWP100W-EVBPA power (W) and efficiency (%) plotted against input voltage at 50Ω load

The SEEK thermal camera photo of the PA is depicted in Figure 23. The thermal performance with EMI filter is very impressive. The temperature rise of the GaN devices is a modest 3°C, while the hottest inductor temperature rises about 9°C above ambient.

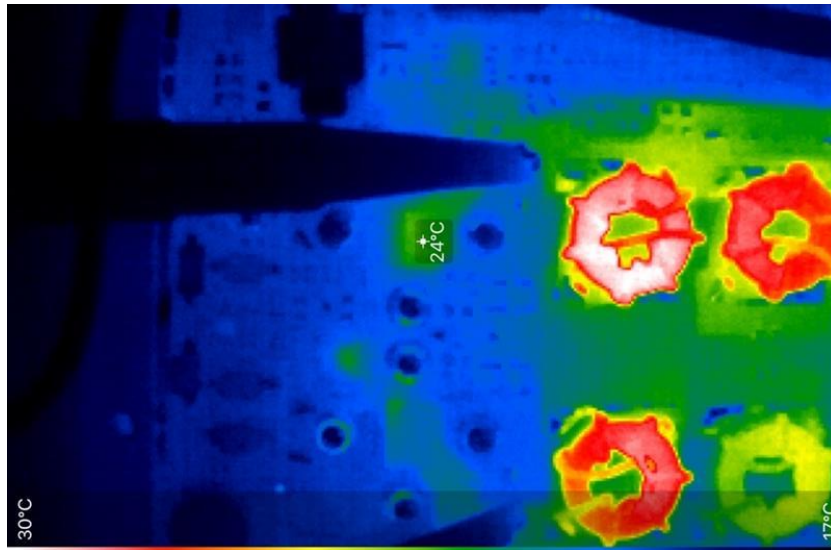


Figure 23 • Thermal measurement of PA with EMI filter at 100W output power

## Technical Resources

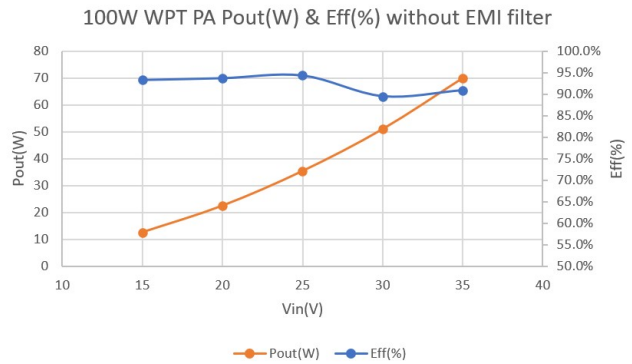
This document and additional technical resources are available for download from [www.gansystems.com](http://www.gansystems.com).

## Appendix A:

Sample Test Data with and without EMI filter

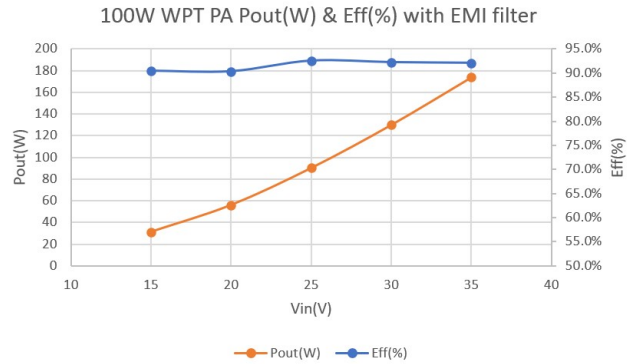
### Test data without EMI filter

| Vin(V) | Iin(A) | Pout(W) | Pin(W) | Eff(%) |
|--------|--------|---------|--------|--------|
| 15     | 0.9    | 12.6    | 13.5   | 93.3%  |
| 20     | 1.2    | 22.5    | 24.0   | 93.8%  |
| 25     | 1.5    | 35.4    | 37.5   | 94.4%  |
| 30     | 1.9    | 51      | 57.0   | 89.5%  |
| 35     | 2.2    | 70      | 77.0   | 90.9%  |



### Test data with EMI filter

| Vin(V) | Iin(A) | Pout(W) | Pin(W) | Eff(%) |
|--------|--------|---------|--------|--------|
| 15     | 2.3    | 31.2    | 34.5   | 90.4%  |
| 20     | 3.1    | 56      | 62.0   | 90.3%  |
| 25     | 3.9    | 90.2    | 97.5   | 92.5%  |
| 30     | 4.7    | 130     | 141.0  | 92.2%  |
| 35     | 5.4    | 174     | 189.0  | 92.1%  |



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